

Notice of References Cited	Application/Control No. 10/040,797	Applicant(s)/Patent Under Reexamination GOLDFINE ET AL.	
	Examiner Jeffrey R. West	Art Unit 2857	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,453,689	09-1995	Goldfine et al.	324/239
	B	US-4,876,511	10-1989	Clark	324/338
*	C	US-5,763,901	06-1998	Komoto et al.	257/99
	D	US-4,209,747	06-1980	Huchital	324/338
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP-56151538-A	11-1981	JP	Isobe et al.	B29D27/00
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Zaretsky et al., "Continuum Properties from Interdigital Electrode Dielectrometry", IEEE Transactions on Electrical Insulation, Vol. 23, No. 6. December 1988.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.